

Notice of References Cited	Application/Control No. 09/993,055	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Emmanuel S. Luk	Art Unit 1722	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3642417	02-1972	Von Holdt	425/443
	B	US-4198371	04-1980	Holmes	264/297
	C	US-5252051	10-1993	Miyamoto et al	425/116
	D	US-5295802	03-1994	Hersbt	425/139
	E	US-5375989	12-1994	Tsutsumi	425/127
	F	US-5849344	12-1998	Eto et al	425/556
	G	US-6056535	05-2000	Shimizu	425/556
	H	US-6348173 B1	02-2002	Anderson	264/318
	I	US-6435855 B1	08-2002	Sakurai	425/139
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.